

<b>Notice of References Cited</b>	Application/Control No. 10/602,369	Applicant(s)/Patent Under Reexamination DOTSON ET AL.	
	Examiner Phallaka Kik	Art Unit 2825	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0022951 A1	02-2002	Heijningen et al.	703/16
*	B	US-2003/0099190 A1	05-2003	Zerbe, Jared L.	370/201
*	C	US-6,941,258 B2	09-2005	Van Heijningen et al.	703/16
*	D	US-7,111,265 B1	09-2006	Tan et al.	716/10
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.